

# **MOSFET Maximum Ratings** T<sub>1</sub> = 25°C unless otherwise noted.

Symbol	Parameter	Ratings	Units		
V <sub>DSS</sub>	Drain-to-Source Voltage	80	V		
V <sub>GS</sub>	Gate-to-Source Voltage	±20	V		
	Drain Current - Continuous ( $V_{GS}$ =10) (Note 1) $T_C$ = 25°CPulsed Drain Current $T_C$ = 25°C		300	Α	
D			See Figure 4		
E <sub>AS</sub>	Single Pulse Avalanche Energy	(Note 2)	820	mJ	
<b>D</b>	Power Dissipation		429	W	
P <sub>D</sub>	Derate Above 25°C		2.86	W/ <sup>o</sup> C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature		-55 to + 175	°C	
R <sub>θJC</sub>	Thermal Resistance, Junction to Case		0.35	°C/W	
R <sub>0JA</sub>	Maximum Thermal Resistance, Junction to Ambient (Note 3)		43	°C/W	

### Notes:

1: Current is limited by bondwire configuration.

2: Starting T<sub>J</sub> = 25°C, L = 0.4mH,  $I_{AS}$  = 64A,  $V_{DD}$  = 40V during inductor charging and  $V_{DD}$  = 0V during time in avalanche. 3:  $R_{0,JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design, while  $R_{\theta JA}$  is determined by the board design. The maximum rating presented here is based on mounting on a 1 in<sup>2</sup> pad of 2oz copper.

# Package Marking and Ordering Information

Device Marking	Device	Package			
FDBL86361	FDBL86361_F085	MO-299A	-	-	-

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Units
Off Cha	racteristics						
B <sub>VDSS</sub>	Drain-to-Source Breakdown Voltage	I <sub>D</sub> = 250μA, V	V <sub>GS</sub> = 0V	80	-	-	V
	Drain-to-Source Leakage Current	V <sub>DS</sub> =80V,		-	-	1	μA
IDSS		$V_{GS} = 0V$	T <sub>J</sub> = 175 <sup>o</sup> C (Note 4)	-	-	1	mA
I <sub>GSS</sub>	Gate-to-Source Leakage Current	V <sub>GS</sub> = ±20V		-	-	±100	nA
	racteristics		050 4				
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I$	$D = 250 \mu A$	2.0	3.0	4.0	V
R <sub>DS(on)</sub>	Drain to Source On Resistance	$I_{\rm D} = 80A$ ,	$T_J = 25^{\circ}C$ $T_J = 175^{\circ}C$ (Note 4)	-	1.1 2.4	1.4 3.1	mΩ mΩ
•	c Characteristics						
•	c Characteristics						
C <sub>iss</sub>	Input Capacitance			-	12800	-	pF
C <sub>iss</sub> C <sub>oss</sub>	Input Capacitance Output Capacitance	— V <sub>DS</sub> = 25V, V — f = 1MHz		-	1925	-	, pF
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance	f = 1MHz		-	1925 139		pF pF
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> R <sub>g</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance	f = 1MHz f = 1MHz	/ <sub>GS</sub> = 0V,		1925 139 2.7		pF pF Ω
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> R <sub>g</sub> Q <sub>g(ToT)</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Total Gate Charge at 10V	$f = 1 MHz$ $f = 1 MHz$ $V_{GS} = 0 \text{ to } 1$	V <sub>GS</sub> = 0V,	-	1925 139 2.7 172	- - - 188	pF pF Ω nC
$\frac{C_{iss}}{C_{oss}}$ $\frac{C_{rss}}{C_{rss}}$ $\frac{R_g}{Q_{g(ToT)}}$ $Q_{g(th)}$	Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Total Gate Charge at 10V Threshold Gate Charge	f = 1MHz f = 1MHz	V <sub>GS</sub> = 0V,	- - - -	1925 139 2.7		pF pF Ω
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> R <sub>g</sub> Q <sub>g(ToT)</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Total Gate Charge at 10V	$f = 1 MHz$ $f = 1 MHz$ $V_{GS} = 0 \text{ to } 1$	V <sub>GS</sub> = 0V,	- - - -	1925 139 2.7 172 23	- - 188 27	pF pF Ω nC nC
$\frac{C_{iss}}{C_{oss}}$ $\frac{C_{rss}}{R_g}$ $\frac{Q_{g(ToT)}}{Q_{g(th)}}$ $\frac{Q_{gg}}{Q_{gd}}$ Switching $t_{on}$	Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Total Gate Charge at 10V Threshold Gate Charge Gate-to-Source Gate Charge	$f = 1 MHz$ $f = 1 MHz$ $V_{GS} = 0 \text{ to } 1$	V <sub>GS</sub> = 0V,	- - - - - -	1925         139         2.7         172         23         51	- - 188 27 -	pF pF Ω nC nC
$\begin{array}{c} C_{iss} \\ C_{oss} \\ C_{rss} \\ R_g \\ Q_{g(ToT)} \\ Q_{g(th)} \\ Q_{gs} \\ Q_{gd} \\ \hline \\ Switchi \\ t_{on} \\ t_{d(on)} \\ \end{array}$	Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Total Gate Charge at 10V Threshold Gate Charge Gate-to-Source Gate Charge Gate-to-Drain "Miller" Charge <b>Daracteristics</b> Turn-On Time	$f = 1MHz$ $f = 1MHz$ $V_{GS} = 0 \text{ to } 1$ $V_{GS} = 0 \text{ to } 2$	$V_{GS} = 0V,$ $0V$ $V_{DD} = 64V$ $V$ $I_D = 80A$	- - - - - -	1925 139 2.7 172 23 51 34	- - 188 27 - -	pF pF Ω nC nC nC nC
$\frac{C_{iss}}{C_{oss}}$ $\frac{C_{rss}}{R_g}$ $\frac{Q_{g(ToT)}}{Q_{g(th)}}$ $\frac{Q_{gs}}{Q_{gd}}$ Switching $\frac{t_{on}}{t_{d(on)}}$ $\frac{t_{r}}{t_{r}}$	Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Total Gate Charge at 10V Threshold Gate Charge Gate-to-Source Gate Charge Gate-to-Drain "Miller" Charge ng Characteristics Turn-On Time Turn-On Delay	$f = 1 MHz$ $f = 1 MHz$ $V_{GS} = 0 \text{ to } 1$	$V_{GS} = 0V,$ $V_{DD} = 64V$ V $I_{D} = 80A$	- - - - - - - - - - -	1925 139 2.7 172 23 51 34 - 42	- - 188 27 - - 128 -	pF pF Ω nC nC nC nC nC nC
$\begin{array}{c} C_{iss} \\ C_{oss} \\ C_{rss} \\ R_g \\ Q_{g(ToT)} \\ Q_{g(th)} \\ Q_{gs} \\ Q_{gd} \\ \hline \\ Switchi \\ t_{on} \\ t_{d(on)} \\ \end{array}$	Input Capacitance         Output Capacitance         Reverse Transfer Capacitance         Gate Resistance         Total Gate Charge at 10V         Threshold Gate Charge         Gate-to-Source Gate Charge         Gate-to-Drain "Miller" Charge <b>Description:</b> Turn-On Time         Turn-On Delay         Rise Time	$f = 1 MHz$ $f = 1 MHz$ $V_{GS} = 0 \text{ to } 1$ $V_{GS} = 0 \text{ to } 2$ $V_{DD} = 40V, 1$	$V_{GS} = 0V,$ $V_{DD} = 64V$ V $I_{D} = 80A$	- - - - - - - - - - - -	1925 139 2.7 172 23 51 34 - 42 73	- - 188 27 - - 128 - -	pF pF Ω nC nC nC nC nC nC s ns

Drain-Source Diode Characteristics

V	Source-to-Drain Diode Voltage	I <sub>SD</sub> =80A, V <sub>GS</sub> = 0V	-	-	1.25	V
V <sub>SD</sub>	Source-to-Drain Diode Voltage	I <sub>SD</sub> = 40A, V <sub>GS</sub> = 0V	-	-	1.2	V
t <sub>rr</sub>	Reverse-Recovery Time	I <sub>F</sub> = 80A, dI <sub>SD</sub> /dt = 100A/μs,	-	117	136	ns
Q <sub>rr</sub>	Reverse-Recovery Charge	V <sub>DD</sub> =64V	-	205	269	nC

Note:

4: The maximum value is specified by design at  $T_J$  = 175°C. Product is not tested to this condition in production.



FDBL86361\_F085 Rev. C1

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